

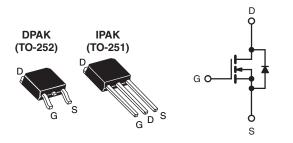
RoHS

COMPLIANT

**HALOGEN FREE** 

### Power MOSFET

PRODUCT SUMMARY				
V <sub>DS</sub> (V)	500			
$R_{DS(on)}(\Omega)$	V <sub>GS</sub> = 10 V	3.0		
Q <sub>g</sub> (Max.) (nC)	19			
Q <sub>gs</sub> (nC)	3.3			
Q <sub>gd</sub> (nC)	13			
Configuration	Single			



N-Channel MOSFET

#### **FEATURES**

- Halogen-free According to IEC 61249-2-21 **Definition**
- Dynamic dV/dt Rating
- Repetitive Avalanche Rated
- Surface Mount (IRFR420, SiHFR420)
- Straight Lead (IRFU420, SiHFU420)
- Available in Tape and Reel
- Fast Switching
- · Ease of Paralleling
- Compliant to RoHS Directive 2002/95/EC

#### **DESCRIPTION**

Third generation Power MOSFETs from Vishay provide the designer with the best combination of fast switching, ruggedized device design, low on-resistance and cost-effictiveness.

The DPAK is designed for surface mounting using vapor phase, infrared, or wave soldering techniques. The straight lead version (IRFU, SiHFU series) is for through-hole mounting applications. Power dissipation levels up to 1.5 W are possible in typical surface mount applications.

ORDERING INFORMATION						
Package	DPAK (TO-252)	DPAK (TO-252)	DPAK (TO-252)	DPAK (TO-252)	IPAK (TO-251)	
Lead (Pb)-free and Halogen-free	SiHFR420-GE3	SiHFR420TR-GE3a	SiHFR420TRL-GE3a	SiHFR420TRR-GE3a	SiHFU420-GE3	
Lead (Pb)-free	IRFR420PbF	IRFR420TRPbFa	IRFR420TRLPbFa	IRFR420TRRPbFa	IRFU420PbF	
	SiHFR420-E3	SiHFR420T-E3a	SiHFR420TL-E3a	-	SiHFU420-E3	
SnPb	IRFR420	IRFR420TR <sup>a</sup>	IRFR420TRL <sup>a</sup>	IRFR420TRR <sup>a</sup>	IRFU420	
	SiHFR420	SiHFR420Ta	SiHFR420TL <sup>a</sup>	-	SiHFU420	

#### Note

See device orientation.

ABSOLUTE MAXIMUM RATINGS $T_C$	= 25 °C, unle	ess otherwis	e noted			
PARAMETER			SYMBOL	LIMIT	UNIT	
Drain-Source Voltage			$V_{DS}$	500	V	
Gate-Source Voltage			$V_{GS}$	± 20		
Continuous Drain Current	V <sub>GS</sub> at 10 V	T <sub>C</sub> = 25 °C	I <sub>D</sub>	2.4		
	VGS at 10 V	T <sub>C</sub> = 100 °C		1.5	Α	
Pulsed Drain Current <sup>a</sup>			I <sub>DM</sub>	8.0		
Linear Derating Factor				0.33	- W/°C	
Linear Derating Factor (PCB Mount)e				0.020		
Single Pulse Avalanche Energy <sup>b</sup>			E <sub>AS</sub>	400	mJ	
Repetitive Avalanche Currenta			I <sub>AR</sub>	2.4	Α	
Repetitive Avalanche Energy <sup>a</sup>			E <sub>AR</sub>	4.2	mJ	
Maximum Power Dissipation	T <sub>C</sub> =	25 °C	D	42	W	
Maximum Power Dissipation (PCB Mount)e	T <sub>A</sub> =	25 °C	$P_{D}$	2.5		
Peak Diode Recovery dV/dt <sup>c</sup>		dV/dt	3.5	V/ns		
Operating Junction and Storage Temperature Range			T <sub>J</sub> , T <sub>stg</sub>	- 55 to + 150	· · · · · ·	
Soldering Recommendations (Peak Temperature)	for	10 s		260 <sup>d</sup>	°C	

- a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11). b.  $V_{DD} = 50$  V, starting  $T_J = 25$  °C, L = 124 mH,  $R_g = 25$   $\Omega$ ,  $I_{AS} = 2.4$  A (see fig. 12). c.  $I_{SD} \le 2.4$  A, dl/dt  $\le 50$  A/µs,  $V_{DD} \le V_{DS}$ ,  $T_J \le 150$  °C. d. 1.6 mm from case.

- When mounted on 1" square PCB (FR-4 or G-10 material).

<sup>\*</sup> Pb containing terminations are not RoHS compliant, exemptions may apply

# IRFR420, IRFU420, SiHFR420, SiHFU420

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THERMAL RESISTANCE RATINGS					
PARAMETER	SYMBOL	TYP.	MAX.	UNIT	
Maximum Junction-to-Ambient	R <sub>thJA</sub>	-	110		
Maximum Junction-to-Ambient (PCB Mount) <sup>a</sup>	R <sub>thJA</sub>	-	50	°C/W	
Maximum Junction-to-Case (Drain)	R <sub>thJC</sub>	-	3.0		

#### Note

a. When mounted on 1" square PCB (FR-4 or G-10 material).

PARAMETER	SYMBOL	TEST CONDITIONS		MIN.	TYP.	MAX.	UNIT
Static							l
Drain-Source Breakdown Voltage	V <sub>DS</sub>	$V_{GS} = 0 \text{ V}, I_D = 250 \mu\text{A}$		500	-	-	٧
V <sub>DS</sub> Temperature Coefficient	$\Delta V_{DS}/T_{J}$	Reference to 25 °C, I <sub>D</sub> = 1 mA		-	0.59	-	V/°C
Gate-Source Threshold Voltage	V <sub>GS(th)</sub>	$V_{DS} = V_{GS}, I_{D} = 250 \mu\text{A}$		2.0	-	4.0	V
Gate-Source Leakage	I <sub>GSS</sub>	,	V <sub>GS</sub> = ± 20 V		-	± 100	nA
Zara Cata Valta a Dusia Comunit		V <sub>DS</sub> =	V <sub>DS</sub> = 500 V, V <sub>GS</sub> = 0 V		-	25	
Zero Gate Voltage Drain Current	I <sub>DSS</sub>	V <sub>DS</sub> = 400 V	/, V <sub>GS</sub> = 0 V, T <sub>J</sub> = 125 °C	-	-	250	μA
Drain-Source On-State Resistance	R <sub>DS(on)</sub>	V <sub>GS</sub> = 10 V	I <sub>D</sub> =1.4 A <sup>b</sup>	-	-	3.0	Ω
Forward Transconductance	9 <sub>fs</sub>	V <sub>DS</sub> :	= 50 V, I <sub>D</sub> = 1.4 A	1.5	-	-	S
Dynamic							
Input Capacitance	C <sub>iss</sub>	V0V		-	360	-	
Output Capacitance	C <sub>oss</sub>	1	$V_{GS} = 0 \text{ V},$ $V_{DS} = 25 \text{ V},$		92	-	pF
Reverse Transfer Capacitance	C <sub>rss</sub>	f = 1.0 MHz, see fig. 5		-	37	-	
Total Gate Charge	Qg			-	-	19	
Gate-Source Charge	Q <sub>gs</sub>	V <sub>GS</sub> = 10 V	$V_{GS} = 10 \text{ V}$ $I_D = 2.1 \text{ A}, V_{DS} = 400 \text{ V},$ see fig. 6 and 13 <sup>b</sup>		-	3.3	nC
Gate-Drain Charge	Q <sub>gd</sub>	See lig. 0 and 13°		-	-	13	
Turn-On Delay Time	t <sub>d(on)</sub>	$V_{DD}$ = 250 V, $I_D$ = 2.1 A, $R_g$ = 18 $\Omega$ , $R_D$ = 120 $\Omega$ , see fig. 10 <sup>b</sup>		-	8.0	-	- ns
Rise Time	t <sub>r</sub>			-	8.6	-	
Turn-Off Delay Time	t <sub>d(off)</sub>			-	33	-	
Fall Time	t <sub>f</sub>			-	16	-	
Internal Drain Inductance	L <sub>D</sub>	Between lead, 6 mm (0.25") from package and center of die contact		-	4.5	-	
Internal Source Inductance	L <sub>S</sub>			-	7.5	-	- nH
Drain-Source Body Diode Characteristic	s						·
Continuous Source-Drain Diode Current	I <sub>S</sub>	MOSFET symbol showing the integral reverse p - n junction diode		-	-	2.4	
Pulsed Diode Forward Current <sup>a</sup>	I <sub>SM</sub>			-	-	8.0	A
Body Diode Voltage	$V_{SD}$	$T_J = 25  ^{\circ}\text{C},  I_S = 2.4  \text{A},  V_{GS} = 0  \text{V}^{\text{b}}$		-	-	1.6	V
Body Diode Reverse Recovery Time	t <sub>rr</sub>	T <sub>J</sub> = 25 °C, I <sub>F</sub> = 2.1 A, dI/dt = 100 A/μs <sup>b</sup>		-	260	520	ns
Body Diode Reverse Recovery Charge	Q <sub>rr</sub>			-	0.70	1.4	μC
Forward Turn-On Time	t <sub>on</sub>	Intrinsic tu	-on is dor	ninated b	y L <sub>S</sub> and	L <sub>D</sub> )	

#### Notes

- a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11).
- b. Pulse width  $\leq 300 \,\mu\text{s}$ ; duty cycle  $\leq 2 \,\%$ .

### TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted

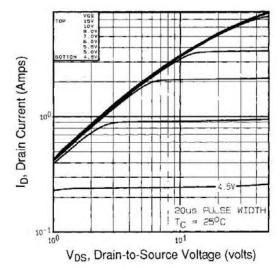


Fig. 1 - Typical Output Characteristics, T<sub>C</sub> = 25 °C

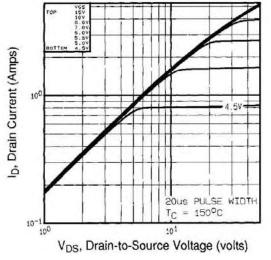


Fig. 2 -Typical Output Characteristics,  $T_C = 150 \, ^{\circ}C$ 

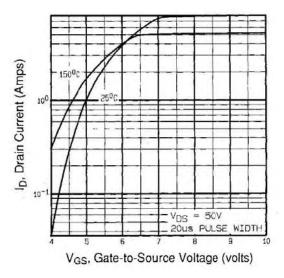


Fig. 3 - Typical Transfer Characteristics

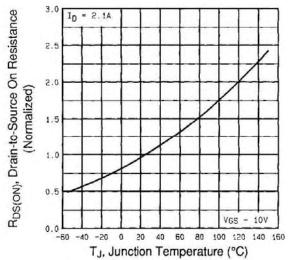


Fig. 4 - Normalized On-Resistance vs. Temperature

# IRFR420, IRFU420, SiHFR420, SiHFU420

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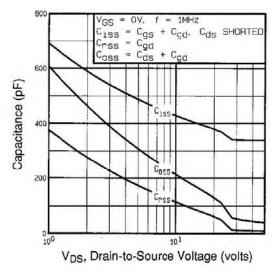


Fig. 5 - Typical Capacitance vs. Drain-to-Source Voltage

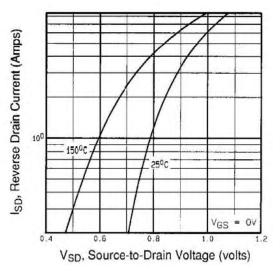


Fig. 7 - Typical Source-Drain Diode Forward Voltage

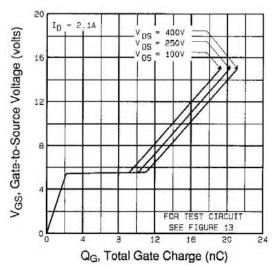


Fig. 6 - Typical Gate Charge vs. Gate-to-Source Voltage

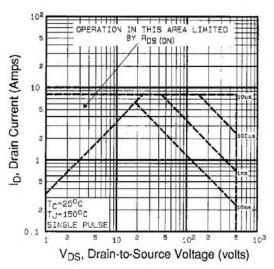


Fig. 8 - Maximum Safe Operating Area

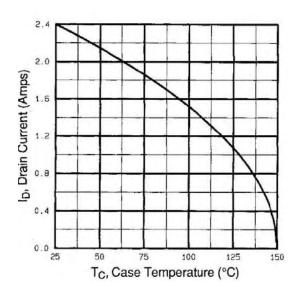


Fig. 9 - Maximum Drain Current vs. Case Temperature

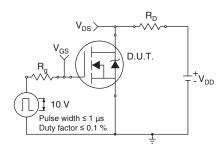


Fig. 10a - Switching Time Test Circuit

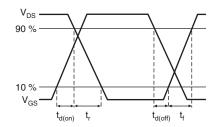


Fig. 10b - Switching Time Waveforms

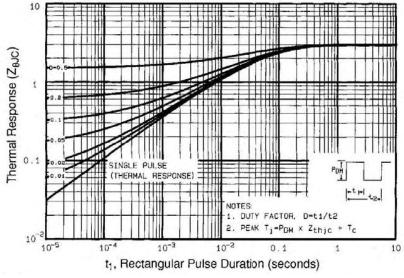


Fig. 11 - Maximum Effective Transient Thermal Impedance, Junction-to-Case

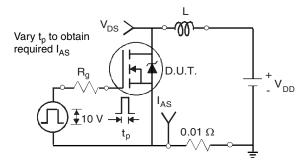


Fig. 12a - Unclamped Inductive Test Circuit

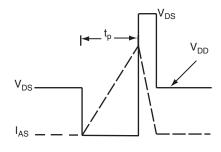


Fig. 12b - Unclamped Inductive Waveforms



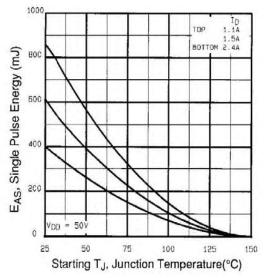


Fig. 12c - Maximum Avalanche Energy vs. Drain Current

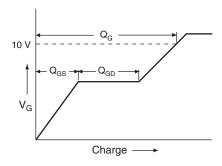


Fig. 13a - Basic Gate Charge Waveform

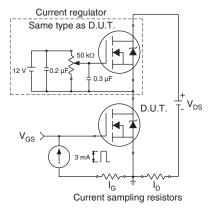
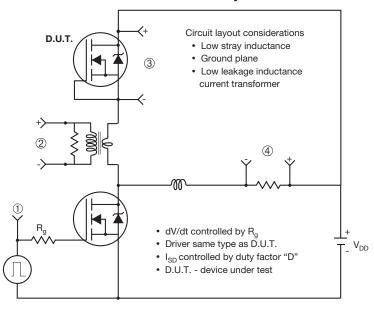


Fig. 13b - Gate Charge Test Circuit

#### Peak Diode Recovery dV/dt Test Circuit



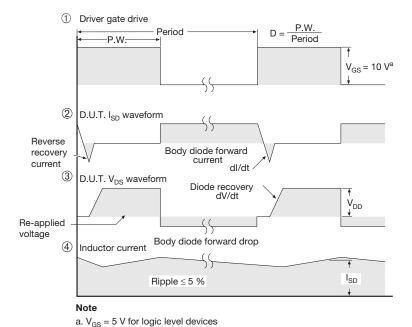


Fig. 14 -For N-Channel

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